

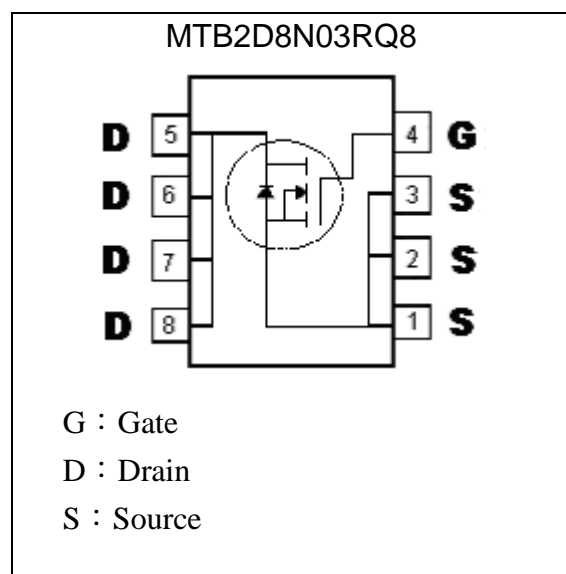
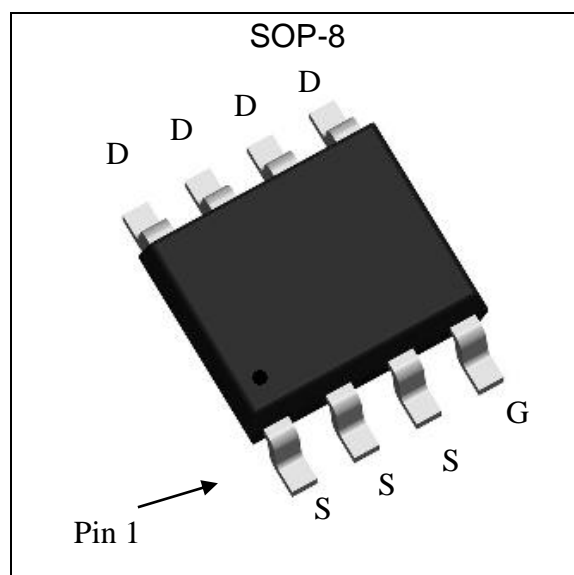
N-Channel Enhancement Mode Power MOSFET

MTB2D8N03RQ8

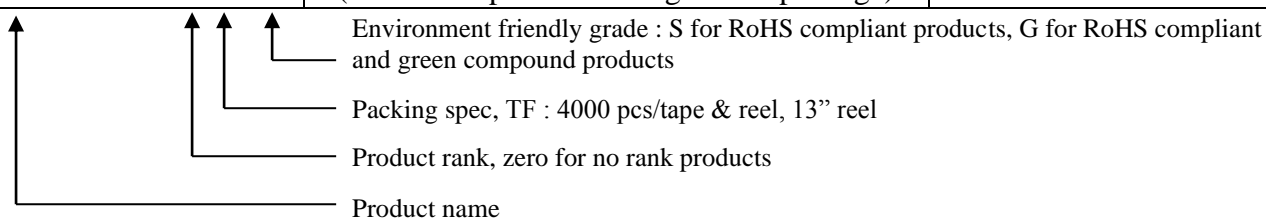
Features

- Single Drive Requirement
- Low On-resistance
- Fast Switching Characteristic
- Pb-free & Halogen-free package

BV_{DSS}	30V
$I_D @ V_{GS}=10V, T_C=25^\circ C$ (silicon limit)	38A
$I_D @ V_{GS}=10V, T_C=25^\circ C$ (package limit)	35A
$R_{DS(on)(typ)} @ V_{GS}=10V, I_D=20A$	2.5 m Ω
$R_{DS(on)(typ)} @ V_{GS}=4.5V, I_D=20A$	3.7 m Ω

Symbol

Outline

Ordering Information

Device	Package	Shipping
MTB2D8N03RQ8-0-TF-G	SOP-8 (RoHS compliant & Halogen-free package)	4000 pcs / Tape & Reel





Absolute Maximum Ratings (Tc=25°C, unless otherwise noted)

Parameter	Symbol	Limits	Unit	
Drain-Source Voltage	V _{DS}	30	V	
Gate-Source Voltage	V _{GS}	±20		
Continuous Drain Current @ T _C =25°C, V _{GS} =10V(silicon limit)	I _D	38	A	
Continuous Drain Current @ T _C =100°C, V _{GS} =10V(silicon limit)		24		
Continuous Drain Current @ T _C =25°C, V _{GS} =10V(package limit)		35		
Continuous Drain Current @ T _A =25°C, V _{GS} =10V		17		
Continuous Drain Current @ T _A =70°C, V _{GS} =10V		13.6		
Pulsed Drain Current	I _{DM}	68 *1		
Avalanche Current @ L=0.1mH(Typical)	I _{AS}	17		
Avalanche Energy @ L=0.5mH	E _{AS}	25	mJ	
Repetitive Avalanche Energy @ L=0.5mH	E _{AR}	2 *2		
Total Power Dissipation	P _D	T _C =25°C	12	W
		T _C =100°C	4.8	
		T _A =25 °C	2.3	
		T _A =70 °C	1.5	
Operating Junction and Storage Temperature	T _j , T _{stg}	-55~+150	°C	

Note : *1. Pulse width limited by maximum junction temperature
 *2. Duty cycle ≤ 1%

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case	R _{θJC}	10.5	°C/W
Thermal Resistance, Junction-to-ambient (Note)	R _{θJA}	53	

Note : 40°C / W when mounted on a 1 in² pad of 2 oz copper, t≤10s; 125 °C/W when mounted on minimum pad.

Characteristics (Tc=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	30	-	-	V	V _{GS} =0V, I _D =250μA
V _{GS(th)}	1	-	2.5		V _{DS} =V _{GS} , I _D =250μA
G _{FS}	-	28.3	-	S	V _{DS} =5V, I _D =10A
I _{GSS}	-	-	±100	nA	V _{GS} =±20V, V _{DS} =0V
I _{DSS}	-	-	1	μA	V _{DS} =24V, V _{GS} =0V
	-	-	10		V _{DS} =24V, V _{GS} =0V, T _j =85°C
*R _{DS(ON)}	-	2.5	3.3	mΩ	V _{GS} =10V, I _D =20A
	-	3.7	5.5		V _{GS} =4.5V, I _D =20A

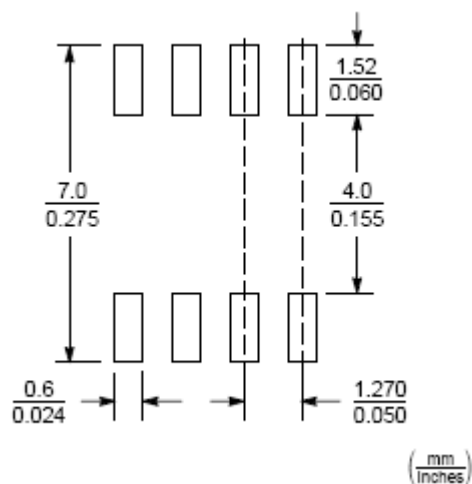
Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Dynamic					
Qg *1, 2	-	28	-	nC	V _{DS} =15V, V _{GS} =10V, I _D =20A
Qgs *1, 2	-	6	-		
Qgd *1, 2	-	5	-		
Ciss	-	1613	-	pF	V _{DS} =15V, V _{GS} =0V, f=1MHz
Coss	-	1057	-		
Crss	-	104	-		
Dynamic					
t _{d(ON)} *1, 2	-	14	-	ns	V _{DS} =15V, V _{GS} =10V, I _D =20A, R _{GS} =3Ω
t _r *1, 2	-	14	-		
t _{d(OFF)} *1, 2	-	38	-		
t _f *1, 2	-	8	-		
R _g	-	1.0	-	Ω	f=1MHz
Source-Drain Diode Ratings and Characteristics					
I _S *1	-	-	17	A	
I _{SM} *3	-	-	68		
V _{SD} *1	-	0.81	1.2	V	I _S =15A, V _{GS} =0V
t _{rr}	-	31	-	ns	I _F =20A, dI _F /dt=100A/μs
Q _{rr}	-	16	-	nC	

Note : *1.Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

*2.Independent of operating temperature

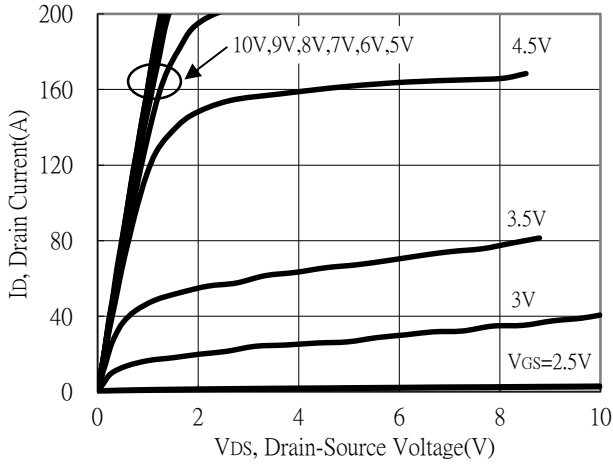
*3.Pulse width limited by maximum junction temperature.

Recommended Soldering Footprint

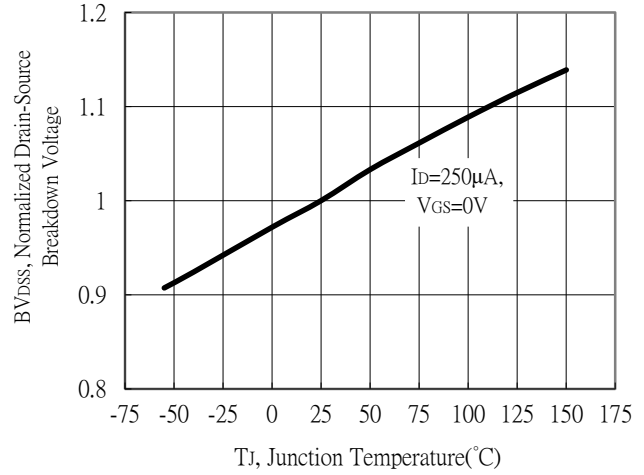


Typical Characteristics

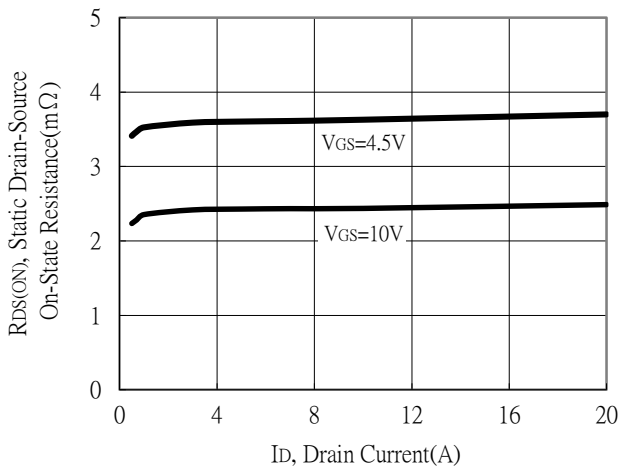
Typical Output Characteristics



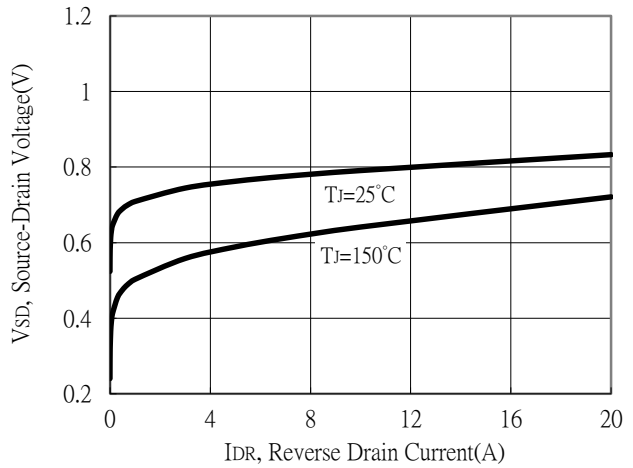
Breakdown Voltage vs Ambient Temperature



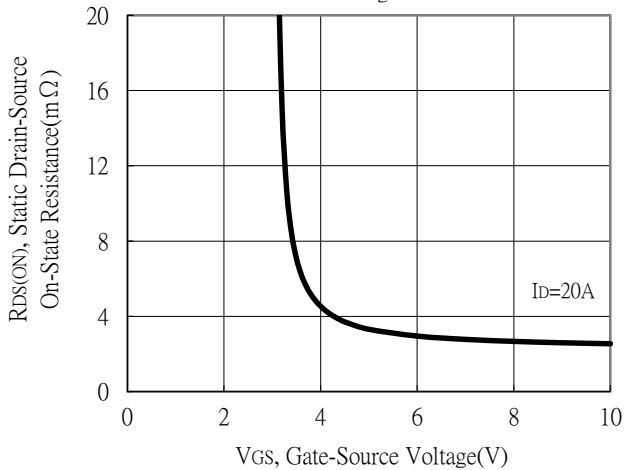
Static Drain-Source On-State resistance vs Drain Current



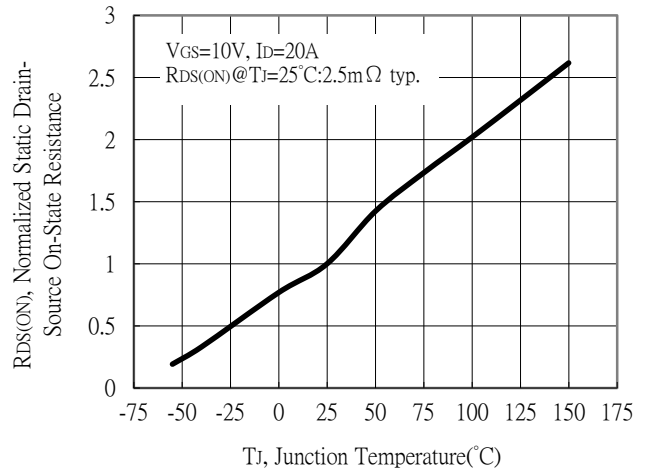
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

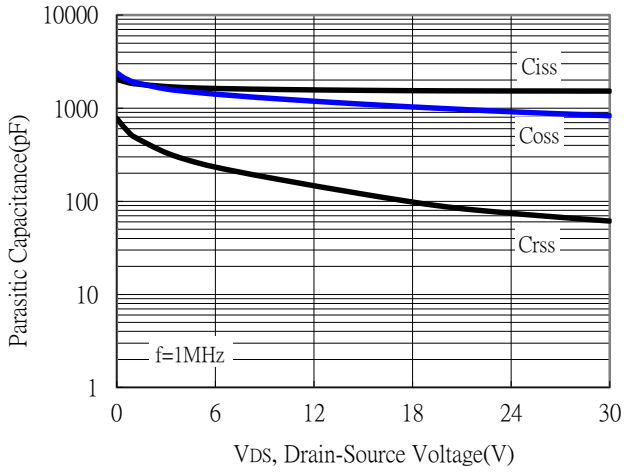


Drain-Source On-State Resistance vs Junction Temperature

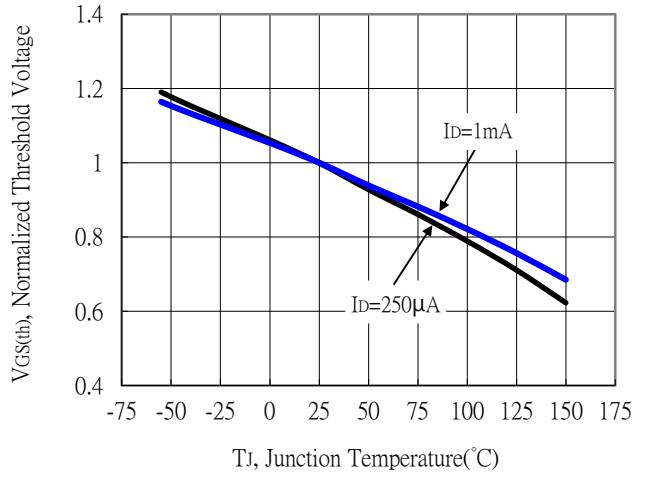


Typical Characteristics(Cont.)

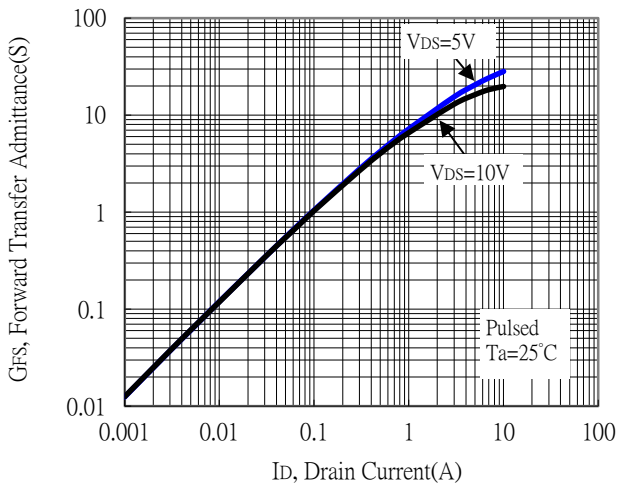
Capacitance vs Drain-to-Source Voltage



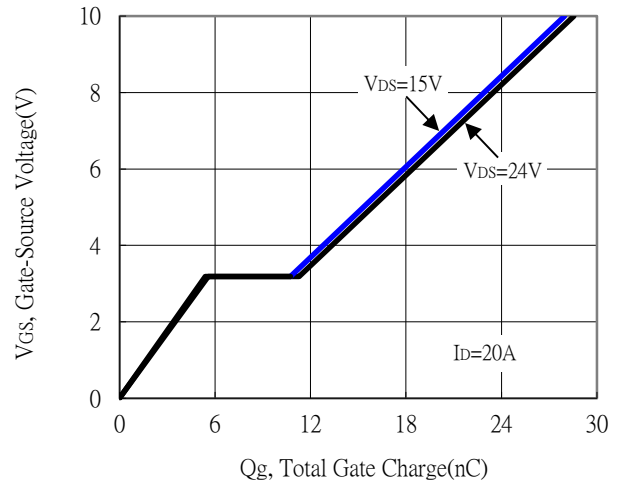
Threshold Voltage vs Junction Temperature



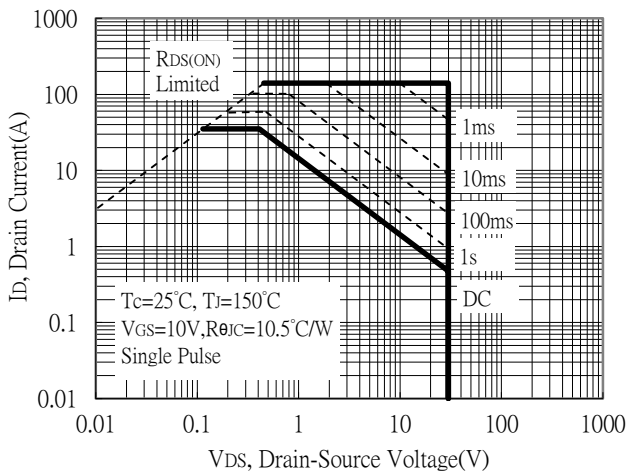
Forward Transfer Admittance vs Drain Current



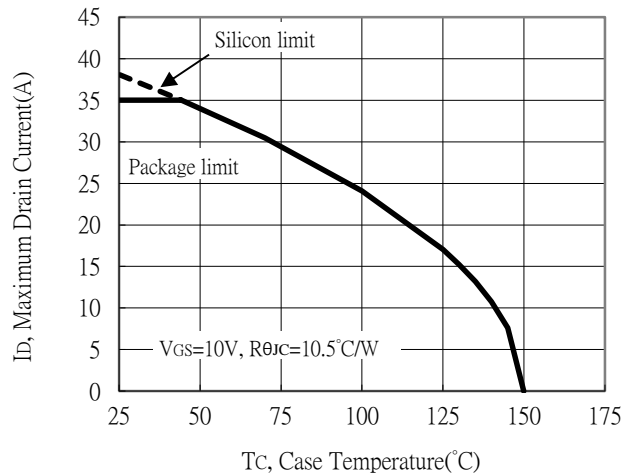
Gate Charge Characteristics



Maximum Safe Operating Area

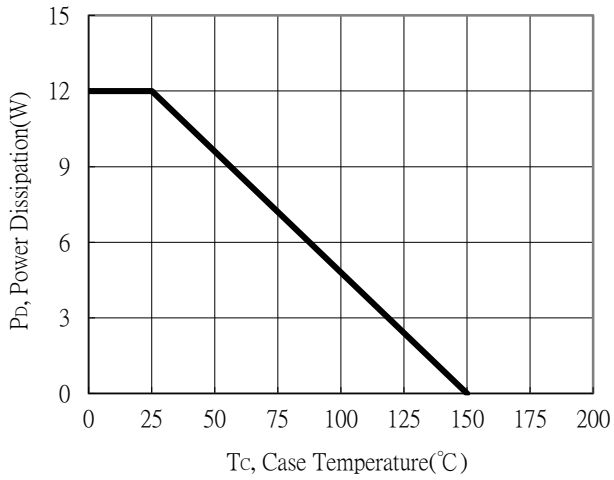


Maximum Drain Current vs Case Temperature

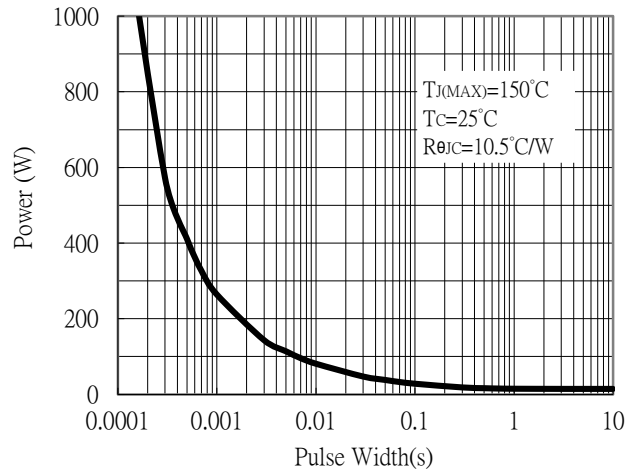


Typical Characteristics(Cont.)

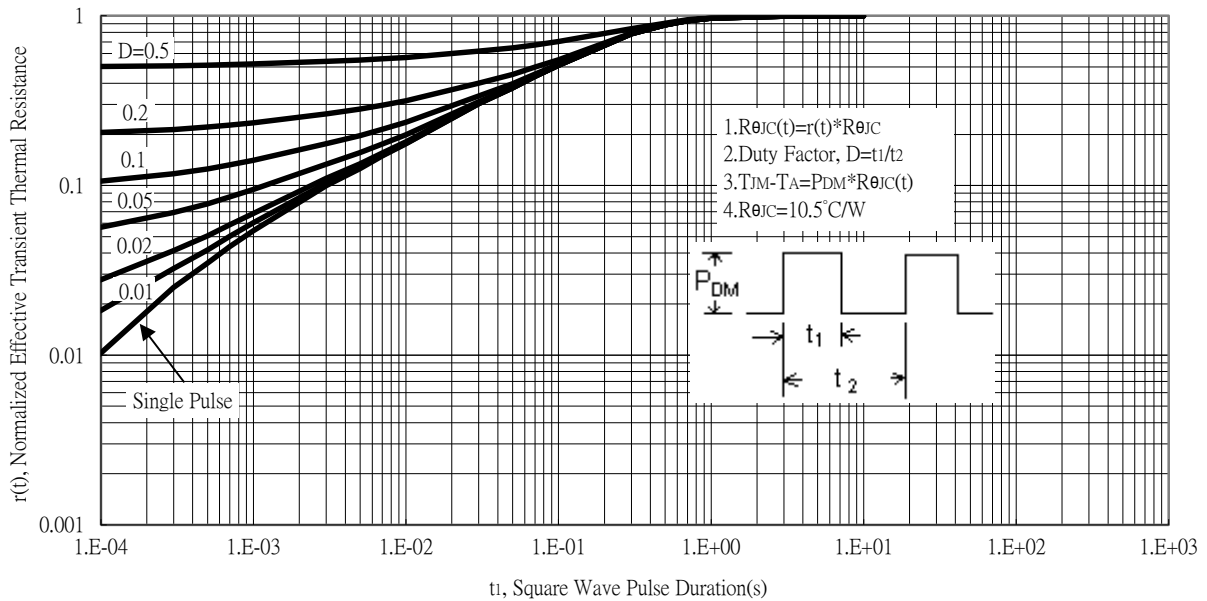
Power Derating Curve



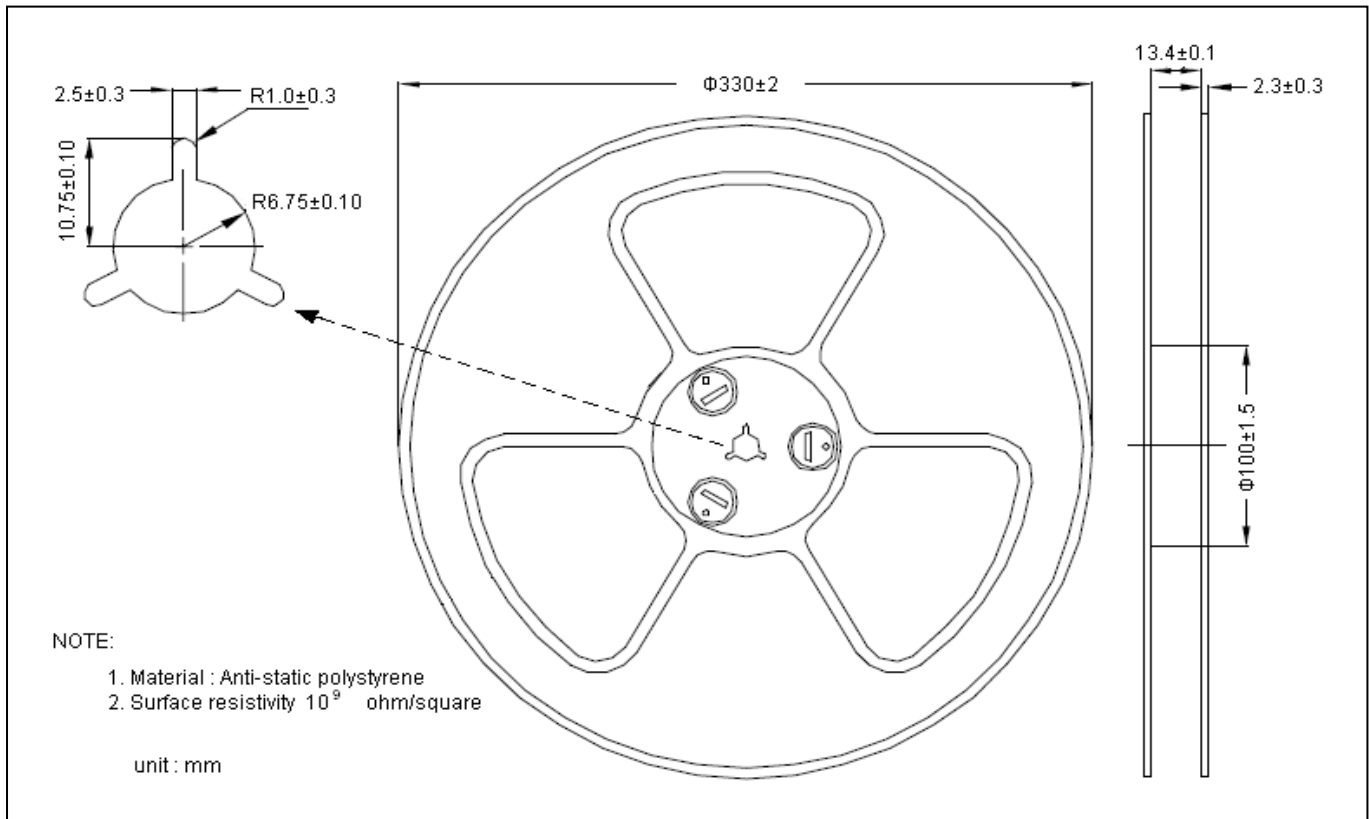
Single Pulse Maximum Power Dissipation



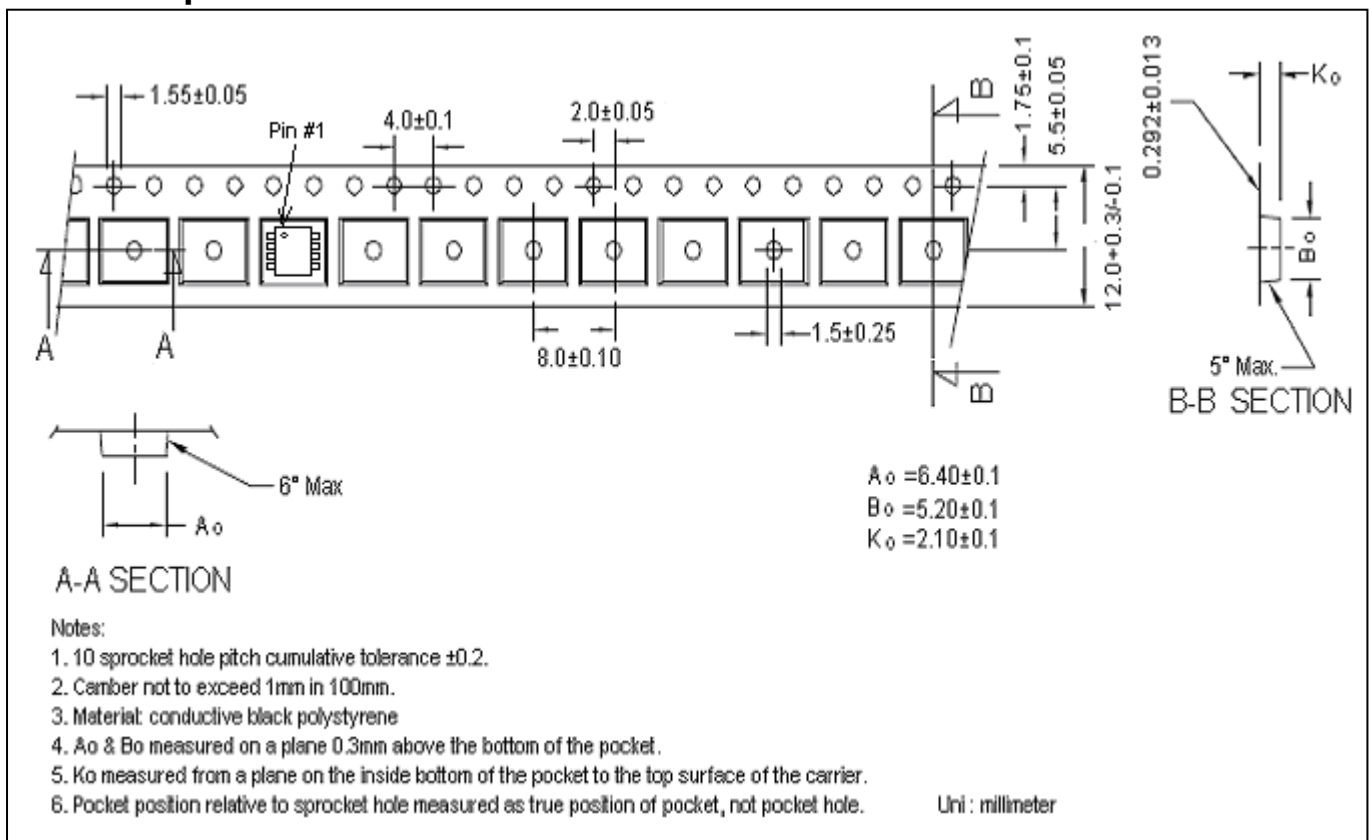
Transient Thermal Response Curves



Reel Dimension



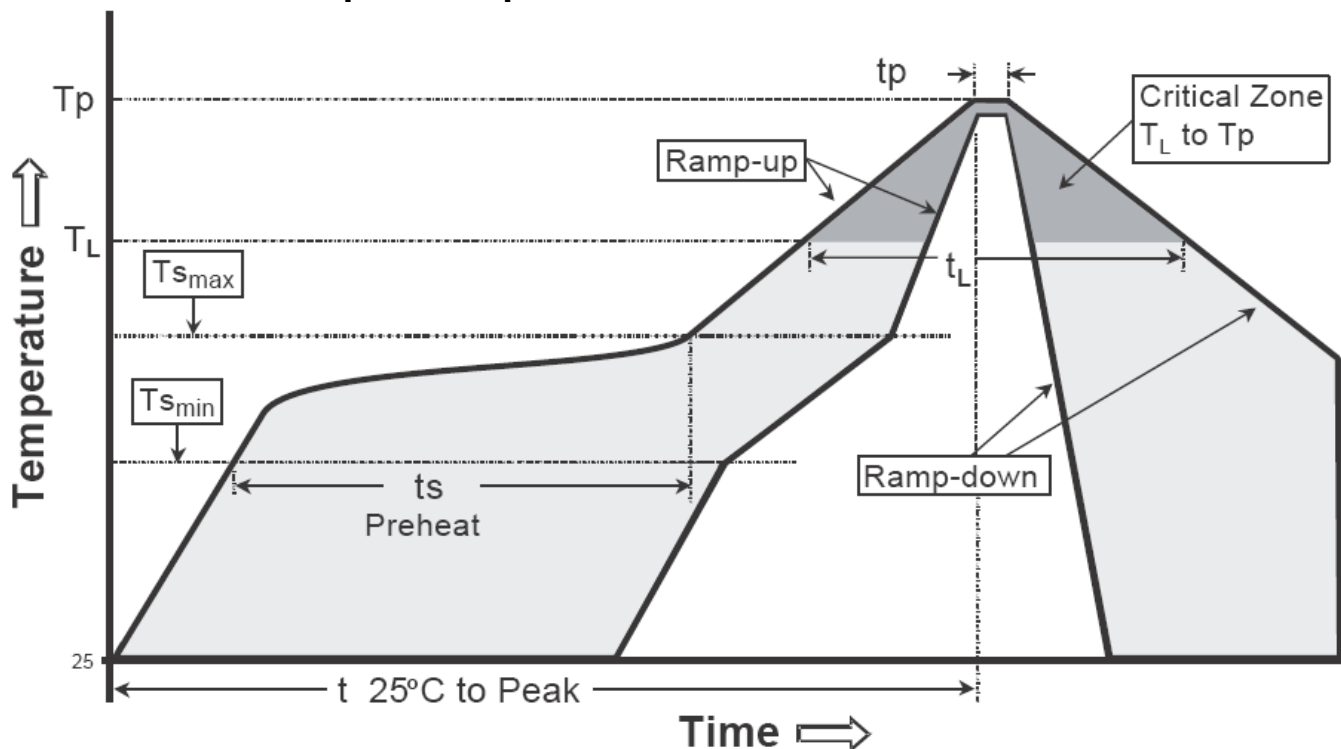
Carrier Tape Dimension



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

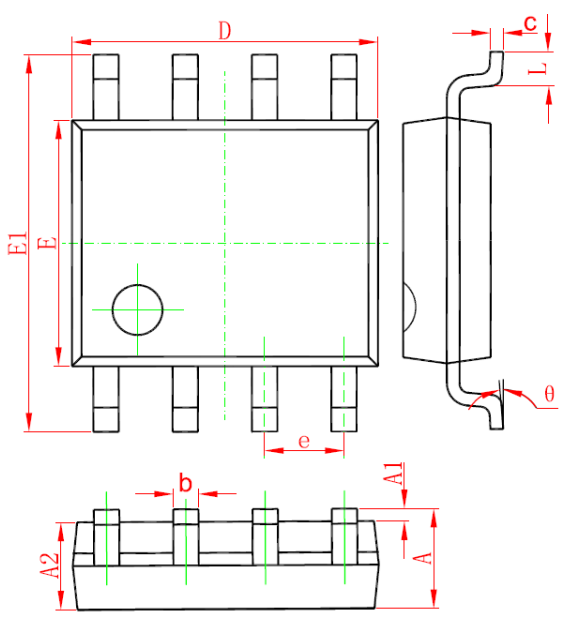
Recommended temperature profile for IR reflow



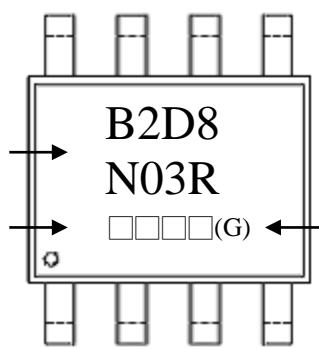
Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Tsmax to Tp)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(ts min to ts max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (TL)	183°C	217°C
- Time (tL)	60-150 seconds	60-150 seconds
Peak Temperature(TP)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

SOP-8 Dimension



Marking:



Device Code → **B2D8**

Date Code → **N03R** ← Production site code

□□□□(G)

Date Code(counting from left to right) :

1st code: year code, the last digit of Christian year

2nd code : month code, Jan→A, Feb→B, Mar→C, Apr→D
 May→E, Jun→F, Jul→G, Aug→H, Sep→J,
 Oct→K, Nov→L, Dec→M

3rd and 4th codes : production serial number, 01~99

Production site code : blank→ JCET, G →GEM

8-Lead SOP-8 Plastic Package
 CYStek Package Code: Q8

*: Typical

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069	E	3.800	4.000	0.150	0.157
A1	0.100	0.250	0.004	0.010	E1	5.800	6.200	0.228	0.244
A2	1.350	1.550	0.053	0.061	e	*1.270		*0.050	
b	0.330	0.510	0.013	0.020	L	0.400	1.270	0.016	0.050
c	0.170	0.250	0.006	0.010	θ	0°	8°	0°	8°
D	4.700	5.100	0.185	0.200					

- Notes: 1.Controlling dimension: millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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